IGBT - Field Stop

600 V, 60 A

FGH60N60SFDTU-F085

Description

Using Novel Field Stop IGBT Technology, ON Semiconductor's new series of Field Stop IGBTs offer the optimum performance for Automotive Chargers, Inverter, and other applications where low conduction and switching losses are essential.

Features

- High Current Capability
- Low Saturation Voltage: $V_{CE(sat)} = 2.2 \text{ V}$ @ $I_C = 60 \text{ A}$
- High Input Impedance
- Fast Switching
- Qualified to Automotive Requirements of AEC-Q101
- This Device is Pb-Free and is RoHS Compliant

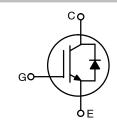
Applications

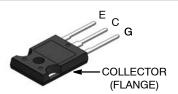
- Automotive chargers, Converters, High Voltage Auxiliaries
- Inverters, PFC, UPS



ON Semiconductor®

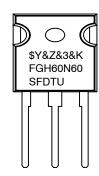
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TO-247-3LD CASE 340CK

MARKING DIAGRAM



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code

&3 = Numeric Date Co &K = Lot Code

FGH60N60SFDTU = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 2 of this data sheet.

ABSOLUTE MAXIMUM RATINGS ($T_C = 25^{\circ}C$ unless otherwise noted)

Descrip	Symbol	Ratings	Unit	
Collector to Emitter Voltage	V _{CES}	600	V	
Gate to Emitter Voltage	V _{GES}	±20	V	
Transient Gate-to-Emitter Voltage]	±30	V	
Collector Current	T _C = 25°C	I _C	120	Α
	T _C = 100°C]	60	Α
Pulsed Collector Current	T _C = 25°C	I _{CM} (Note 1)	180	Α
Maximum Power Dissipation	T _C = 25°C	P _D	378	W
	T _C = 100°C	1	151	W
Operating Junction Temperature		TJ	-55 to +150	°C
Storage Temperature Range	T _{stg}	-55 to +150	°C	
Maximum Lead Temp. for Soldering Purpo	ses, 1/8" from Case for 5 Seconds	TL	300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Parameter	Symbol	Тур	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$ (IGBT)	0.33	°C/W
Thermal Resistance, Junction to Case	$R_{\theta JC}$ (Diode)	1.1	°C/W
Thermal Resistance, Junction to Ambient	$R_{ heta JA}$	40	°C/W

PACKAGE MARKING AND ORDERING INFORMATION

	Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
ĺ	FGH60N60SFDTU-F085	FGH60N60SFDTU	TO-247	Tube	N/A	N/A	30

ELECTRICAL CHARACTERISTICS OF THE IGBT (T_C = 25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS	-					
Collector to Emitter Breakdown Voltage	BV _{CES}	V _{GE} = 0 V, I _C = 250 μA	600	-	_	V
Temperature Coefficient of Breakdown Voltage	$\Delta BV_{CES}/\Delta T_{J}$	V_{GE} = 0 V, I_{C} = 250 μA	_	0.4	-	V/°C
Collector Cut-Off Current	I _{CES}	V _{CE} = V _{CES} , V _{GE} = 0 V	-	-	250	μΑ
G-E Leakage Current	I _{GES}	V _{GE} = V _{GES} , V _{CE} = 0 V	_	_	±400	nA
ON CHARACTERISTICs	-					
G-E Threshold Voltage	V _{GE(th)}	$I_C = 250 \mu A, V_{CE} = V_{GE}$	4.0	5.1	6.6	V
Collector to Emitter Saturation Voltage	V _{CE(sat)}	I _C = 60 A, V _{GE} = 15 V	-	2.2	2.9	V
		I _C = 60 A, V _{GE} = 15 V, T _C = 125°C	_	2.4	-	V

^{1.} Repetitive test, Pulse width limited by max. junction temperature.

$\textbf{ELECTRICAL CHARACTERISTICS OF THE IGBT} \ (T_C = 25^{\circ}C \ unless \ otherwise \ noted) \ (continued)$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{ies}	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz	_	2940	_	pF
Output Capacitance	C _{oes}		=	310	-	pF
Reverse Transfer Capacitance	C _{res}		_	100	-	pF
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t _{d(on)}	$V_{CC} = 400 \text{ V}, I_{C} = 60 \text{ A},$	_	26	_	ns
Rise Time	t _r	$R_G = 5 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 25^{\circ}C$	_	54	_	ns
Turn-Off Delay Time	t _{d(off)}		_	134	_	ns
Fall Time	t _f		_	18	62	ns
Turn-On Switching Loss	E _{on}		_	1.97	-	mJ
Turn-Off Switching Loss	E _{off}		_	0.57	-	mJ
Total Switching Loss	E _{ts}			2.54	-	mJ
Turn-On Delay Time	t _{d(on)}	V _{CC} = 400 V, I _C = 60 A,	-	26	-	ns
Rise Time	t _r	$R_G = 5 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 125^{\circ}C$	_	50	-	ns
Turn-Off Delay Time	t _{d(off)}		_	142	-	ns
Fall Time	t _f		_	24	-	ns
Turn-On Switching Loss	E _{on}		_	2.5	_	mJ
Turn-Off Switching Loss	E _{off}		_	0.8	_	mJ
Total Switching Loss	E _{ts}		_	3.2	_	mJ
Total Gate Charge	Qg	V _{CE} = 400 V, I _C = 60 A, V _{GE} = 15 V	-	188	_	nC
Gate to Emitter Charge	Q _{ge}		_	21	-	nC
Gate to Collector Charge	Q _{gc}	1	_	98	_	nC

ELECTRICAL CHARACTERISTICS OF THE DIODE ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit
V_{FM}	Diode Forward Voltage	I _F = 30 A	T _C = 25°C	_	1.9	2.6	V
			T _C = 125°C	-	1.7	_	
t _{rr}	Diode Reverse Recovery Time	$I_F = 30 \text{ A}, \text{ di}_F/\text{dt} = 200 \text{ A}/\mu\text{s}$	T _C = 25°C	-	55	_	ns
			T _C = 125°C	-	204	_	
Q _{rr}	Diode Reverse Recovery Charge		T _C = 25°C	_	125	_	nC
			T _C = 125°C	-	895	_	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL PERFORMANCE CHARACTERISTICS

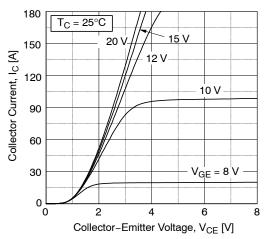


Figure 1. Typical Output Characteristics

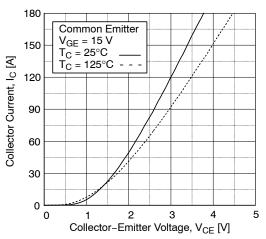


Figure 3. Typical Saturation Voltage Characteristics

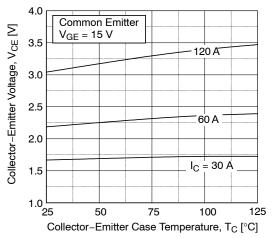


Figure 5. Saturation Voltage vs. Case Temperature at Variant Current Level

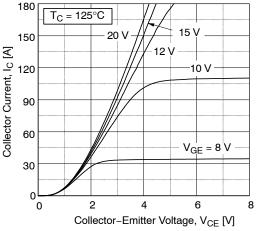


Figure 2. Typical Output Characteristics

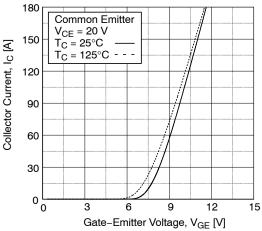


Figure 4. Transfer Characteristics

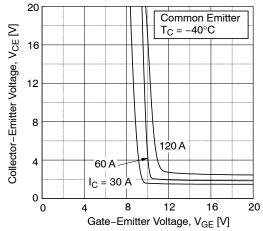


Figure 6. Saturation Voltage vs V_{GE}

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

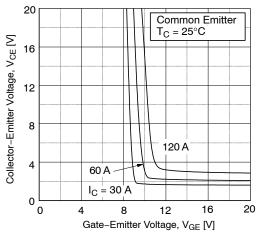


Figure 7. Saturation Voltage vs. V_{GE}

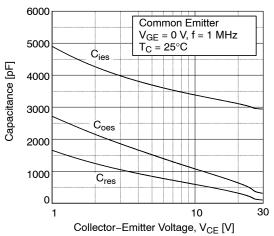


Figure 9. Capacitance Characteristics

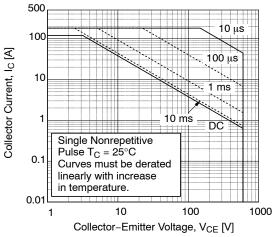


Figure 11. SOA Characteristics

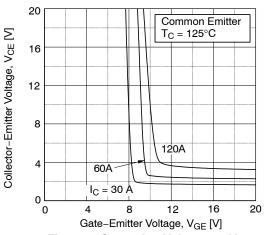


Figure 8. Saturation Voltage vs. V_{GE}

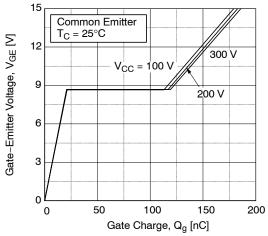


Figure 10. Gate Charge Characteristics

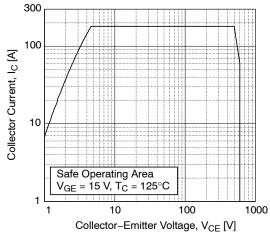


Figure 12. Turn-Off Switching SOA Characteristics

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

6000

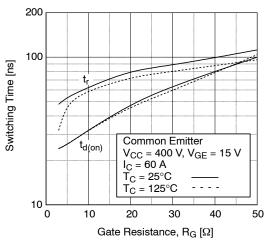
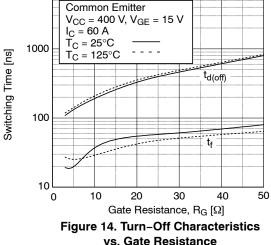


Figure 13. Turn-On Characteristics vs. Gate Resistance



vs. Gate Resistance

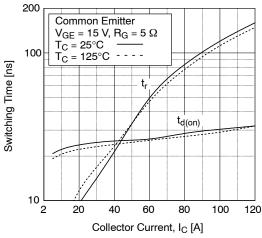


Figure 15. Turn-On Characteristics vs. Collector Current

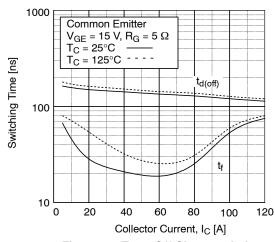


Figure 16. Turn-Off Characteristics vs. Collector Current

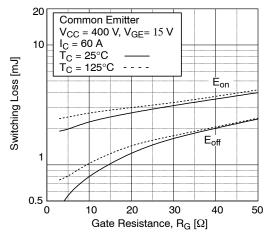


Figure 17. Switching Loss vs. Gate Resistance

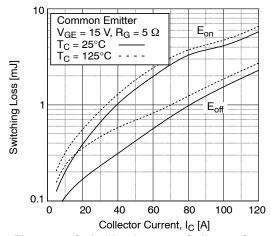


Figure 18. Switching Loss vs. Collector Current

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

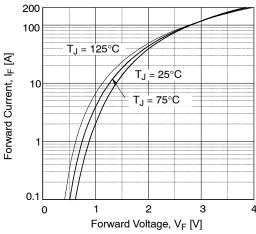


Figure 19. Forward Characteristics

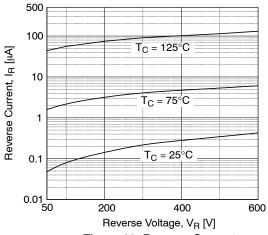


Figure 20. Reverse Current

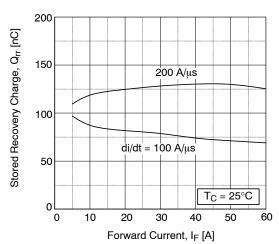


Figure 21. Stored Charge

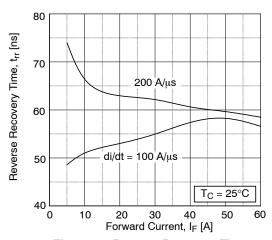


Figure 22. Reverse Recovery Time

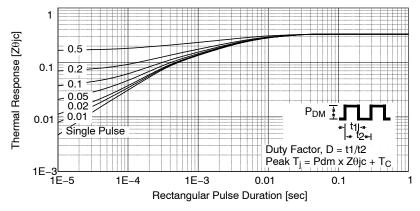


Figure 23. Transient Thermal Impedance of IGBT

TO-247-3LD SHORT LEAD

CASE 340CK ISSUE A





- A. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DRAWING CONFORMS TO ASME Y14.5 2009.
- D. DIMENSION A1 TO BE MEASURED IN THE REGION DEFINED BY L1.
- E. LEAD FINISH IS UNCONTROLLED IN THE REGION DEFINED BY L1.

GENERIC MARKING DIAGRAM*



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



DIM	MILLIMETERS				
DIIVI	MIN	NOM	MAX		
Α	4.58	4.70	4.82		
A 1	2.20	2.40	2.60		
A2	1.40	1.50	1.60		
b	1.17	1.26	1.35		
b2	1.53	1.65	1.77		
b4	2.42	2.54	2.66		
С	0.51	0.61	0.71		
D	20.32	20.57	20.82		
D1	13.08	~	~		
D2	0.51	0.93	1.35		
E	15.37	15.62	15.87		
E1	12.81	?	~		
E2	4.96	5.08	5.20		
е	~	5.56	~		
L	15.75	16.00	16.25		
L1	3.69	3.81	3.93		
ØΡ	3.51	3.58	3.65		
ØP1	6.60	6.80	7.00		
Q	5.34	5.46	5.58		
S	5.34	5.46	5.58		

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